

## Features

- 700V GaN enhancement-mode transistor
- Normally-off design
- No Qrr (reverse recovery charge)
- Low Qg (gate charge), low Qoss (output charge)
- Integrated ESD protection

## Applications

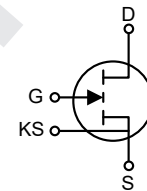
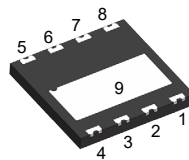
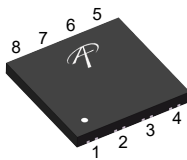
- PFC and PWM stages (LLC, FSFB, TTF) of Server, Telecom, Industrial, UPS, and Solar Inverters

## Product Summary at $T_J = 25^\circ\text{C}$

$V_{DS, \max}$	700V
$R_{DS(on), \max} @ V_{GS} = 6V$	190m $\Omega$
$Q_{g, \text{typ}} @ V_{DS} = 400V$	2.8nC
$I_{D, \text{pulse}}$	20.5A
$Q_{oss} @ V_{DS} = 400V$	24.5nC
$Q_{rr} @ V_{DS} = 400V$	0nC



## Pin Configuration



## Pin Information

Gate	Drain	Kelvin Source	Source
4	5, 6, 7, 8	3	1, 2, 9

## Ordering Information

Ordering Part Number	Package Type	Form	Shipping Quantity
AONV190V70GA1	DFN8x8	Tape and Reel	1500

Contact local sales office for full product datasheet.

## Absolute Maximum Ratings

( $T_J = 25^\circ\text{C}$ , unless otherwise noted)

Symbol	Parameter		AONV190V70GA1	Units
$V_{DS, \max}$	Drain Source Voltage	$V_{GS} = 0V$ , $T_J = -55^\circ\text{C}$ to $150^\circ\text{C}$	700	V
$V_{DS, \text{trans}}$	Drain Source Voltage Transient <sup>(1)</sup>	$V_{GS} = 0V$	800	
$V_{DS, \text{pulse}}$	Drain Source Voltage Pulsed <sup>(2)</sup>	$T_C = 25^\circ\text{C}$ , total time < 10 hours $T_C = 125^\circ\text{C}$ , total time < 1 hour	750	
$I_D$	Continuous Drain Current	$T_C = 25^\circ\text{C}$	11.5	A
$I_{D, \text{pulse}}$	Pulsed Drain Current <sup>(3)</sup>	$T_C = 25^\circ\text{C}$ , $V_{GS} = 6V$ , $t_{\text{pulse}} = 10\mu\text{s}$	20.5	
		$T_C = 125^\circ\text{C}$ , $V_{GS} = 6V$ , $t_{\text{pulse}} = 10\mu\text{s}$	11.5	

## Absolute Maximum Ratings

( $T_J = 25^\circ\text{C}$ , unless otherwise noted)

Symbol	Parameter		AONV190V70GA1	Units
$V_{GS}$	Gate Source Voltage, Continuous	$T_J = -55^\circ\text{C}$ to $150^\circ\text{C}$	-6 to 7	V
$V_{GS, \text{pulse}}$	Gate Source Voltage, Pulsed	$T_J = -55^\circ\text{C}$ to $150^\circ\text{C}$ , $t_{\text{pulse}} = 50\text{ns}$ , $f = 100\text{kHz}$ , open drain	-20 to 10	V
$P_{\text{tot}}$	Power Dissipation <sup>(4)</sup>	$T_C = 25^\circ\text{C}$	82	W
$T_{J, \text{stg}}$	Junction and Storage Temperature Range		-55 to 150	$^\circ\text{C}$

## Thermal Characteristics

Symbol	Parameter	Typ	Max	Note	Units
$R_{\theta JA}$	Thermal Resistance Junction-to-Ambient <sup>(5)</sup>	66			$^\circ\text{C/W}$
$R_{\theta JC}$	Thermal Resistance Junction-to-Case	1.49	1.86 ???		$^\circ\text{C/W}$
$T_{\text{sold}}$	Maximum Reflow Soldering Temperature	260		MSL3	$^\circ\text{C}$

## Electrical Characteristics

( $T_J = 25^\circ\text{C}$ , unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 12.2\text{mA}$	$T_J = 25^\circ\text{C}$ $T_J = 150^\circ\text{C}$	1.2 1.7	1.7 2.5	V
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS} = 700\text{V}$ , $V_{GS} = 0\text{V}$	$T_J = 25^\circ\text{C}$ $T_J = 150^\circ\text{C}$	0.45 6	20	$\mu\text{A}$
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS} = 6\text{V}$ , $V_{DS} = 0\text{V}$ , $T_J = 25^\circ\text{C}$		60		$\mu\text{A}$
$R_{DS(on)}$	Drain-Source On-State-Resistance	$V_{GS} = 6\text{V}$ , $I_D = 3.9\text{A}$	$T_J = 25^\circ\text{C}$ $T_J = 150^\circ\text{C}$	138 300	190	m $\Omega$
<b>DYNAMIC</b>						
$C_{iss}$	Input Capacitance	$V_{GS} = 0\text{V}$ , $V_{DS} = 400\text{V}$ , $f = 100\text{kHz}$		96		pF
$C_{oss}$	Output Capacitance			30		
$C_{rss}$	Reverse Transfer Capacitance			0.5		
$C_{o(er)}$	Effective Output Capacitance Energy Related <sup>(6)</sup>	$V_{GS} = 0\text{V}$ , $V_{DS} = 0$ to $400\text{V}$		43		pF
$C_{o(tr)}$	Effective Output Capacitance Time Related <sup>(7)</sup>			60		
$R_G$	Gate Resistance	$f = 5\text{MHz}$ , open drain		5.8		$\Omega$
<b>SWITCHING</b>						
$Q_g$	Gate Charge	$V_{GS} = 0$ to $6\text{V}$ , $V_{DS} = 400\text{V}$ , $I_D = 3.9\text{A}$		2.8		nC
$Q_{gs}$	Gate Source Charge			0.25		
$Q_{gd}$	Gate Drain Charge			1.1		
$V_{\text{plat}}$	Gate Plateau Voltage	$V_{DS} = 400\text{V}$ , $I_D = 3.9\text{A}$		2.2		V
$Q_{oss}$	Output Charge	$V_{GS} = 0\text{V}$ , $V_{DS} = 0$ to $400\text{V}$		24.5		nC
$t_{d(on)}$	Turn-On Delay Time	$V_{DS} = 400\text{V}$ ; $I_D = 8\text{A}$ ; $L = 318\mu\text{H}$ ; $V_{GS} = 6\text{V}$ ; $R_{on} = 10\Omega$ ; $R_{off} = 2\Omega$ ;		1.4		ns
$t_{d(off)}$	Turn-Off Delay Time			1.7		
$t_r$	Rise Time			4		
$t_f$	Fall Time			4		

## Electrical Characteristics (Continued)

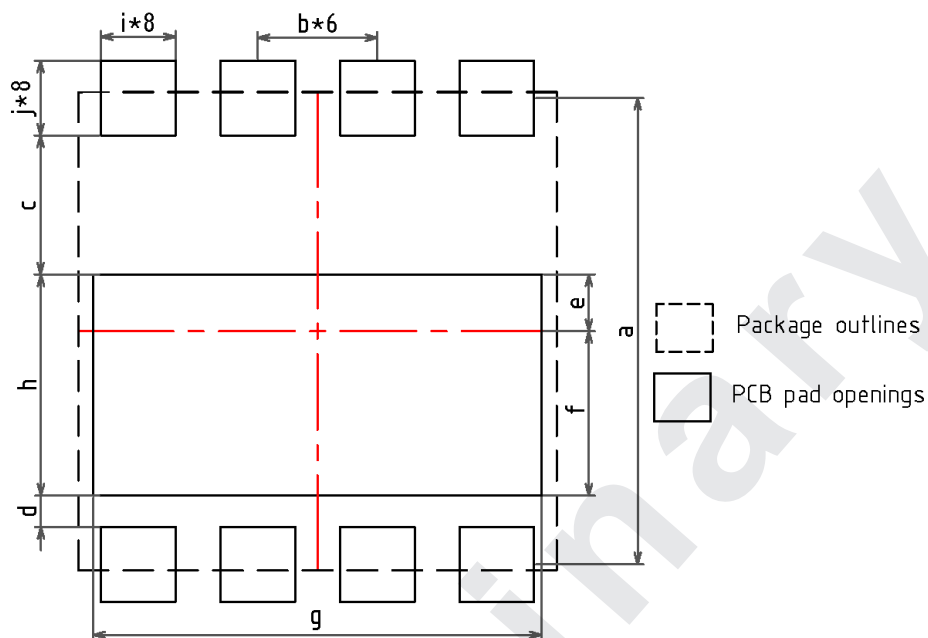
( $T_J = 25^\circ\text{C}$ , unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>REVERSE CONDUCTION</b>						
$V_{SD}$	Source-Drain Reverse Voltage	$V_{GS} = 0\text{V}$ , $I_S = 3.9\text{A}$ , $T_J = 25^\circ\text{C}$		2.6		V
$I_{S, \text{pulse}}$	Reverse Pulsed Current	$V_{GS} = 6\text{V}$ , $t_{\text{pulse}} = 10\mu\text{s}$			20.5	A
$Q_{rr}$	Reverse Recovery Charge	$V_R = 400\text{V}$ , $I_S = 3.9\text{A}$ , $dv/dt = 1\text{kA}/\mu\text{s}$		0		nC
$t_{rr}$	Reverse Recovery Time			0		ns
$I_{rrm}$	Peak Reverse Recovery Current			0		A

### Notes:

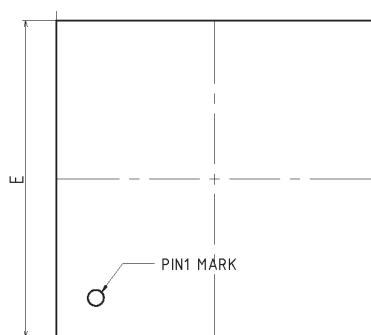
- $V_{DS, \text{transient}}$  is intended for non-repetitive events,  $t_{\text{PULSE}} < 200\mu\text{s}$ .
- $V_{DS, \text{pulse}}$  is intended for repetitive pulse,  $t_{\text{PULSE}} < 100\text{ns}$ .
- Limit was extracted from characterization test, not measured during production.
- Power dissipation, and consequently max. current ratings are obtained using max. thermal resistance and max. temperature of  $150^\circ\text{C}$ .
- $R_{thJA}$  is determined with the device mounted on one square inch of copper pad, single layer 2oz copper on FR4 board.
- $C_{O(er)}$  is the fixed capacitance that gives the same stored energy as  $C_{OSS}$  while VDS is rising from 0 to 400 V.
- $C_{O(tr)}$  is the fixed capacitance that gives the same charging time as  $C_{OSS}$  while VDS is rising from 0 to 400 V.

## Recommended PCB Footprint

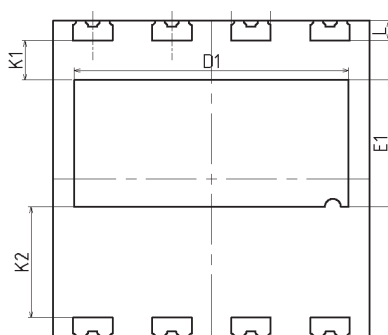


SYMBOL	DIMENSION	SYMBOL	DIMENSION
a	7.800	f	2.750
b	2.000	g	7.500
c	2.325	h	3.700
d	0.525	i	1.400
e	0.950	j	1.250
Notes: (1) All dimension are in millimeters. (2) Drawing is not to scale.			

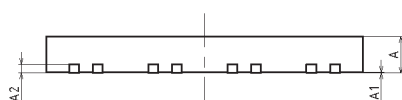
## Package Dimensions, DFN8x8



top view



Bottom view



side view

	MIN	NUM	MAX
A	0.80	0.90	1.00
A1	0.00	0.02	0.05
A2	0.203REF		
b	0.95	1.00	1.05
D	8.00 BSC		
D1	6.84	6.94	7.04
E	8.00 BSC		
E1	3.10	3.20	3.30
K1	0.90	1.00	1.10
K2	2.70	2.80	2.90
e	2.00 BSC		
L	0.40	0.50	0.60

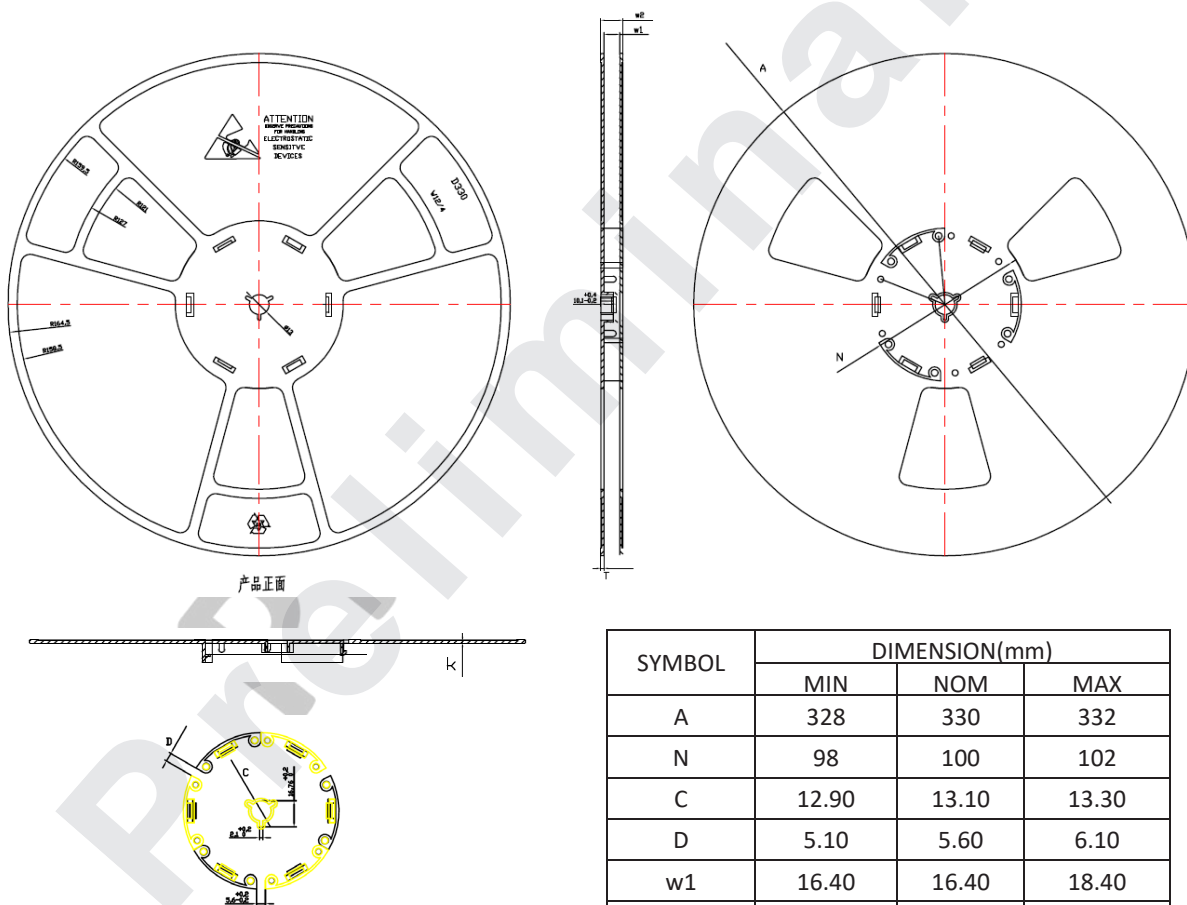
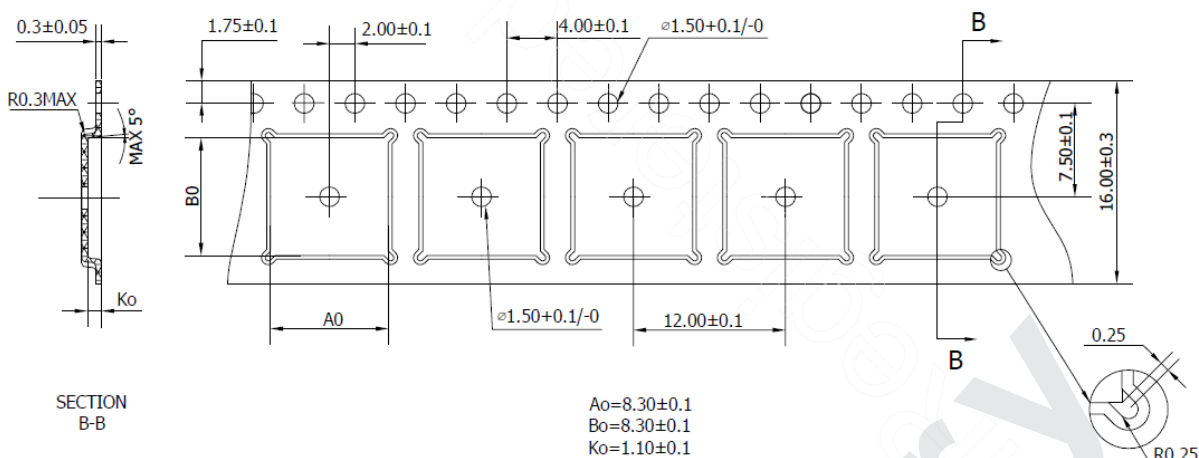


LOGO - AOS Logo
070V65GA1 - Part number code
F - Fab code
A - Assembly location code
Y - Year code
W - Week code
L&T - Assembly lot code

### Notes:

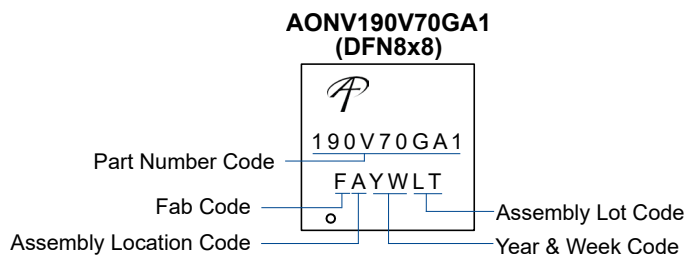
1. Dimension and tolerance conform to ASME Y14.5-2009.
2. All dimensions are in millimeters.
3. Lead coplanarity will be 0.1 millimeters max.
4. Complies with JEDEC MO-229.
5. Drawing is not to scale.
6. Dimensions do not include mold protrusion.
7. Package outline exclusive of metal burr dimensions.

# Tape and Reel Dimensions, DFN8x8



SYMBOL	DIMENSION(mm)		
	MIN	NOM	MAX
A	328	330	332
N	98	100	102
C	12.90	13.10	13.30
D	5.10	5.60	6.10
w1	16.40	16.40	18.40
w2	20.60	20.60	22.60
T	1.95	2.10	2.25
K	1.30	1.40	1.55

## Part Marking



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